

J647-T1-A-VB Datasheet

P-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^c	Q _g (Typ.)		
- 20	$0.080 \text{ at V}_{GS} = -4.5 \text{ V}$	- 3.1	4.3 nC		
- 20	0.100 at V _{GS} = - 2.5 V	- 2.3	4.5110		

FEATURES

Halogen-free According to IEC 61249-2-21 Definition



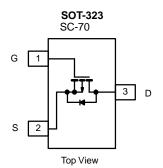
- Compliant to RoHS Directive 2002/95/EC

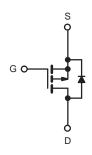


HALOGEN FREE

APPLICATIONS

- Load Switch
- DC/DC Converters





P-Channel MOSFET

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	- 20	V	
Gate-Source Voltage	V _{GS}	± 12	V	
Continuous Drain Current /T 450 °C)	T _C = 25 °C		- 3.1	
	T _C = 70 °C] , [- 2.1	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	I _D	- 1.4 ^{a, b}	
	T _A = 70 °C		- 1.1 ^{a, b}	А
Pulsed Drain Current	I _{DM}	- 6		
Continuous Source-Drain Diode Current	T _C = 25 °C	I.	- 0.4	
	T _A = 25 °C	I _S	- 0.3	
	T _C = 25 °C		0.5	
Marian and David Dispiration	T _C = 70 °C	P _D	0.3	w
Maximum Power Dissipation	T _A = 25 °C		0.4 ^{a, b}	VV
	T _A = 70 °C		0.3 ^{a, b}	
Operating Junction and Storage Temperature Rang	T _J , T _{stg}	- 50 to 150	°C	
Soldering Recommendations (Peak Temperature)			260	

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. t = 10 s.
- c. Based on T_C = 25 °C.



THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{a, b}	t ≤ 10 s	R _{thJA}	250	300	°C/W		
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	225	270	5/ * *		

Notes:

- a. Surface mounted on 1" x 1" FR4 board.
- b. Maximum under steady state conditions is 360 °C/W.

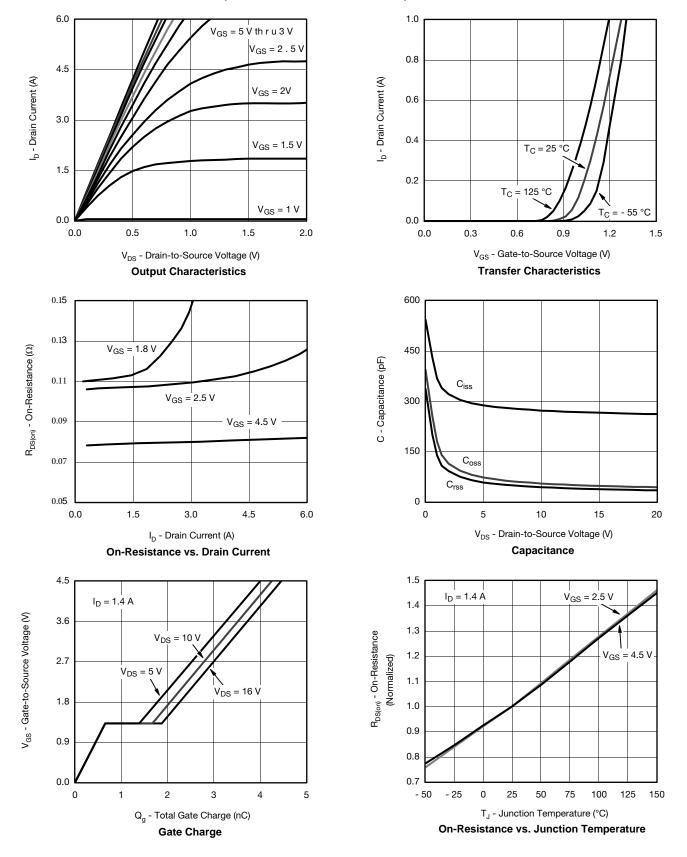
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, } I_{D} = -250 \mu\text{A}$	- 20			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	1 - 250		- 14		mV/°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	I _D = - 250 μA		2.4		
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = - 250 μA	- 0.45		- 1.5	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA
Zara Cata Valtaga Praia Current	000	V _{DS} = - 20 V, V _{GS} = 0 V			- 1	
Zero Gate Voltage Drain Current		V _{DS} = - 20 V, V _{GS} = 0 V, T _J = 55 °C			- 10	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 2			Α
	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 1.4 A	0.080			
Drain-Source On-State Resistance ^a		V _{GS} = - 2.5 V, I _D = - 1.2 A		0.100		Ω
		V _{GS} = - 1.8 V, I _D = - 0.3 A				1
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 5 V, I _D = - 1.4 A		5		S
Dynamic ^b						
Input Capacitance	C _{iss}			272		
Output Capacitance	C _{oss}	V _{DS} = - 10 V, V _{GS} = 0 V, f = 1 MHz		55		pF
Reverse Transfer Capacitance	C _{rss}			44		1
T. 10 . 0		$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -1.4 \text{ A}$		4.3	6.5	nC
Total Gate Charge	Q_g	50 5		2.7	4.1	
Gate-Source Charge	Q _{gs}	$V_{DS} = -10 \text{ V}, V_{GS} = -2.5 \text{ V}, I_{D} = -1.4 \text{ A}$		0.7		
Gate-Drain Charge	Q_{gd}			1.0		
Gate Resistance	R _q	f = 1 MHz	1.4	7	14	Ω
Turn-On Delay Time	t _{d(on)}			12	20	
Rise Time	t _r	$V_{DD} = -10 \text{ V}, R_1 = 9.1 \Omega$		20	30	
Turn-Off DelayTime		$I_D \cong -1.1 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_g = 1 \Omega$		23	35	
Fall Time	t _f			9	18	
Turn-On Delay Time	t _{d(on)}			5	10	ns
Rise Time	t _r	$V_{DD} = -10 \text{ V}, R_1 = 9.1 \Omega$		10	20	
Turn-Off DelayTime	t _{d(off)}	$I_D \cong -1.1 \text{ A}, V_{GEN} = -8 \text{ V}, R_g = 1 \Omega$		18	27	
Fall Time	t _f	Ĭ		7	14	
Drain-Source Body Diode Characterist						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 2.4	
Pulse Diode Forward Current ^a	I _{SM}	Ü			- 6	Α
Body Diode Voltage	V _{SD}	I _F = - 0.7 A		- 0.8	- 1.2	V
Body Diode Reverse Recovery Time	t _{rr}	·		18	27	ns
Body Diode Reverse Recovery Charge	Q _{rr}			7	14	nC
Reverse Recovery Fall Time	t _a			7		
Reverse Recovery Rise Time	t _b			11		ns

Notes:

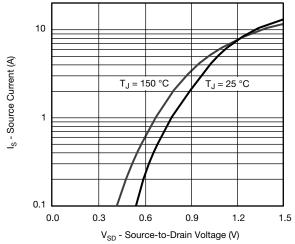
- a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

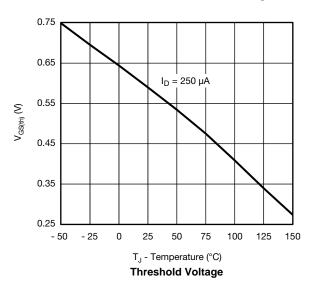








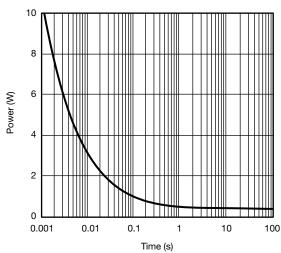
Source-Drain Diode Forward Voltage



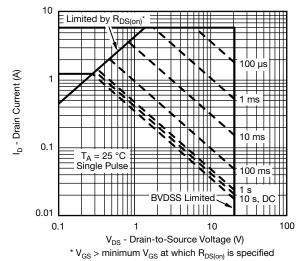
0.32
| I_D = 1.4 A |
| T_J = 125 °C |
| T_J = 25 °C |
| T_J = 25 °C |
| T_J = 3 4 5

V_{GS} - Gate-to-Source Voltage (V)

On-Resistance vs. Gate-to-Source Voltage

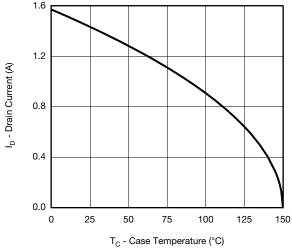


Single Pulse Power, Junction-to-Ambient

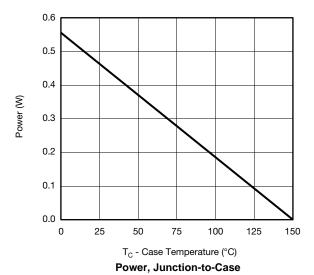


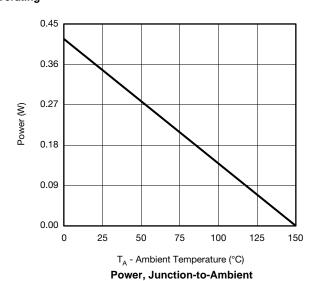
Safe Operating Area, Junction-to-Ambient





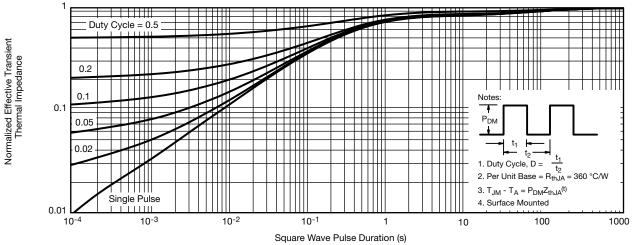
Current Derating*



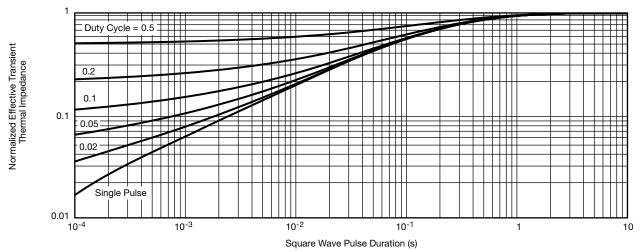


* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





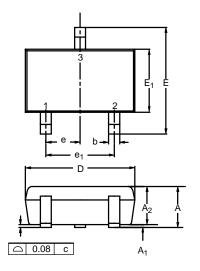
Normalized Thermal Transient Impedance, Junction-to-Ambient

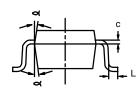


Normalized Thermal Transient Impedance, Junction-to-Foot



SC-70: 3-LEADS



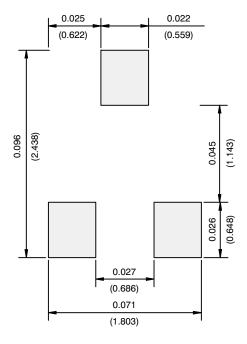


.90 - .80 .25	Nom	1.10 0.10 1.00 0.40	Min 0.035 - 0.031	Nom	0.043 0.004 0.039	
- .80 .25	-	0.10	- 0.031	- - -	0.004	
.25	- -	1.00		1		
.25	1			-	0.039	
	1	0.40	0.040			
10			0.010	_	0.016	
. 10	-	0.25	0.004	-	0.010	
.80	2.00	2.20	0.071	0.079	0.087	
.80	2.10	2.40	0.071	0.083	0.094	
.15	1.25	1.35	0.045	0.049	0.053	
0.65BSC				0.026BSC	;	
.20	1.30	1.40	0.047	0.051	0.055	
.10	0.20	0.30	0.004	0.008	0.012	
7°Nom 7°Nom						
	10	7°Nom	7°Nom		7°Nom 7°Nom	

DWG: 5549



RECOMMENDED MINIMUM PADS FOR SC-70: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)



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